



TEST REPORT

<p>KCTL KCTL Inc. 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea TEL: 82-31-285-0894 FAX: 82-505-299-8311 www.kctl.co.kr</p>	<p>Report No.: KR20-SRF0229-A Page (1) of (16)</p>	
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1. Client

- Name : Samsung Electronics Co., Ltd.
- Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
- Date of Receipt : 2020-07-08

2. Use of Report : Certification

3. Name of Product / Model : Tablet PC / SM-T570

4. Manufacturer / Country of Origin : Samsung Electronics Co., Ltd. / Vietnam

5. FCC ID : A3LSMT570

6. Date of Test : 2020-08-25 to 2020-09-01

7. Location of Test : Permanent Testing Lab On Site Testing (Address: Address of testing location)

8. Test method used : FCC Part 15 Subpart C, 15.247

9. Test Result : Refer to the test result in the test report

Affirmation	Tested by	Technical Manager
	Name : Taeyoung Kim 	Name : Seungyong Kim 

2020-09-10

KCTL Inc.

As a test result of the sample which was submitted from the client, this report does not guarantee the whole product quality. This test report should not be used and copied without a written agreement by KCTL Inc.

REPORT REVISION HISTORY

Date	Revision	Page No
2020-09-02	Originally issued	-
2020-09-10	Updated	7

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Note. The report No. KR20-SRF0229 is superseded by the report No. KR20-SRF0229-A.

General remarks for test reports

Nothing significant to report.



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1. General information

Client : Samsung Electronics Co., Ltd.
Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677,
Rep. of Korea
Manufacturer : Samsung Electronics Co., Ltd.
Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677,
Rep. of Korea
Factory : Samsung Electronics Vietnam Thai Nguyen Co., Ltd (SEVT)
Address : Yen binh Industrial Park, Dong Tien Ward, Pho Yen Town Thai Nguyen
Province, Vietnam
Laboratory : KCTL Inc.
Address : 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea
Accreditations : FCC Site Designation No: KR0040, FCC Site Registration No: 687132
VCCI Registration No. : R-20080, G-20078, C-20059, T-20056
Industry Canada Registration No. : 8035A
KOLAS No.: KT231

2. Device information

Equipment under test : Tablet PC
Model : SM-T570
Modulation technique : Bluetooth(BDR/EDR)_GFSK, $\pi/4$ DQPSK, 8DPSK
Bluetooth(BLE)_GFSK
WIFI(802.11a/b/g/n/ac/ax)_DSSS, OFDM, OFDMA
NFC_ASK
Number of channels : Bluetooth(BDR/EDR)_79 ch / Bluetooth(BLE)_40 ch
802.11b/g/n/ac/ax_HT20/VHT20/HE20 : 13 ch
UNII-1: 4 ch (20 MHz), 2 ch (40 MHz), 1 ch (80 MHz)
UNII-2A: 4 ch (20 MHz), 2 ch (40 MHz), 1 ch (80 MHz)
UNII-2C: 12 ch (20 MHz), 6 ch (40 MHz), 3 ch (80 MHz)
UNII-3: 5 ch (20 MHz), 2 ch (40 MHz), 1 ch (80 MHz)
NFC: 1 ch
Power source : DC 3.85 V
Antenna specification : WIFI/Bluetooth(BDR/EDR/BLE)_LDS carrier Antenna
NFC_FPCB Antenna
Antenna gain : WIFI/Bluetooth(BDR/EDR/BLE): ANT 1: -2.50 dBi, ANT 2: -2.50 dBi
UNII-1 ANT 1: -3.20 dBi, ANT 2: -3.70 dBi
UNII-2A ANT 1: -3.20 dBi, ANT 2: -3.80 dBi
UNII-2C ANT 1: -6.20 dBi, ANT 2: -6.70 dBi
UNII-3 ANT 1: -6.50 dBi, ANT 2: -6.40 dBi

Frequency range : Bluetooth(BDR/EDR/BLE)_2 402 MHz ~ 2 480 MHz
2 412 MHz ~ 2 472 MHz (802.11b/g/n/ac/ax_HT20/VHT20/HE20)
UNII-1: 5 180 MHz ~ 5 240 MHz (802.11a/n/ac/ax_HT20/VHT20/HE20)
UNII-1: 5 190 MHz ~ 5 230 MHz (802.11n/ac/ax_HT40/VHT40/HE40)
UNII-1: 5 210 MHz (802.11ac/ax_VHT80/HE80)
UNII-2A: 5 260 MHz ~ 5 320 MHz (802.11a/n/ac/ax_HT20/VHT20/HE20)
UNII-2A: 5 270 MHz ~ 5 310 MHz (802.11n/ac/ax_HT40/VHT40/HE40)
UNII-2A: 5 290 MHz (802.11ac/ax_VHT80/HE80)
UNII-2C: 5 500 MHz ~ 5 720 MHz (802.11a/n/ac/ax_HT20/VHT20/HE20)
UNII-2C: 5 510 MHz ~ 5 710 MHz (802.11n/ac/ax_HT40/VHT40/HE40)
UNII-2C: 5 530 MHz ~ 5 690 MHz (802.11ac/ax_VHT80/HE80)
UNII-3: 5 745 MHz ~ 5 825 MHz (802.11a/n/ac/ax_HT20/VHT20/HE20)
UNII-3: 5 755 MHz ~ 5 795 MHz (802.11n/ac/ax_HT40/VHT40/HE40)
UNII-3: 5 775 MHz (802.11ac/ax_VHT80/HE80)
NFC_13.56 MHz

Software version : T570.001

Hardware version : REV1.0

Test device serial No. : Conducted(R32N600Z9BF)
Radiated(R32N60101GJ)

Operation temperature : -30 °C ~ 50 °C

3. Introduction

This report referenced from the FCC ID : A3LSMT575

Based on their similarity, the FCC Part 15C (equipment class: DSS) reuses the original model's result and do spot-check, following the FCC KDB 484596 D01 v01.

And the applicant takes full responsibility that the test data as referenced in this report represent compliance for this FCC ID.

3.1 Difference

The FCC ID: A3LSMT570 shares the same enclosure and circuit board as FCC ID: A3LSMT575. The WIFI/BT/BLE/NFC antenna and surrounding circuitry and layout are identical between these two units. The only difference between the FCC ID: A3LSMT575 and FCC ID: A3LSMT570 is to remove the GSM/WCDMA/LTE related parts (receiver, LFEMID, MMBB PAM, HB PAMID and filters from FCC ID:A3LSMT575.

As for all bands, they have been verified and the parent model test results under FCC ID : A3LSMT575 shall remain representative of FCC ID : A3LSMT570.

Note. The Product equality letter includes detailed information about the differences between FCC ID: A3LSMT575 and FCC ID: A3LSMT570.

3.2 Spot check verification data (Band-edge & Spurious emission)

Test band	Test item	Test mode	Channel	Measured frequency (MHz)	SM-T575 (dB μ V)		SM-T570 (dB μ V)		Deviation (dB)	
					Avg.	Peak	Avg.	Peak	Avg.	Peak
BT	Band edge	GFSK	78	2 483.5 ~ 2 500	-	47.02	-	48.24	-	-1.22
	RSE		78	4 960	-	42.16	-	40.36	-	1.8
	Band edge	8DPSK	78	2 483.5 ~ 2 500	-	46.20	-	47.42	-	-1.22
	RSE		78	4 960	-	41.80	-	39.81	-	1.99

Notes:

- For FCC ID: A3LSMT570 has been verified the performance as for Bluetooth identical with the FCC ID: A3LSMT575.
- Comparison of two models, upper deviation is within 3 dB range and all test results are under FCC technical limits.
- The test procedure(s) in this report were performed in accordance as following.
 - ◆ KDB 484596 D01 v01

3.3 Reference Detail

Reference application that contains the reused reference data in the individual test reports.

Equipment Class	Reference FCC ID	Application Type	Reference Test report Number	Exhibit Type	Variant Test Report Number	Date Reused
DTS	A3LSMT575	Original	KP20-SRF0209 (802.11b/g/n/ac)	Test report	KR20-SRF0231	All
			KP20-SRF0214 (802.11ax)	Test report	KR20-SRF0234	All
			KP20-SRF0208 (Bluetooth LE)	Test report	KR20-SRF0230	All
DSS	A3LSMT575	Original	KP20-SRF0207 (Bluetooth)	Test report	KR20-SRF0229	All
NII	A3LSMT575	Original	KP20-SRF0210 (802.11a/n/ac)	Test report	KR20-SRF0233	All
			KP20-SRF0215 (802.11ax)	Test report	KR20-SRF0235	All
			KR20-SRF0216 (DFS)	Test report	-	All
DXX	A3LSMT575	Original	KP20-SRF0211 (NFC)	Test report	KR20-SRF0232	All



4. Summary of tests

FCC Part section(s)	Parameter	Test Condition	Test results
15.205(a), 15.209(a)	Spurious emission	Radiated	Pass
	Band-edge, restricted band		Pass

Notes:

1. According to exploratory test no any obvious emission were detected from 9 kHz to 30 MHz. Although these tests were performed other than open field site, adequate comparison measurements were confirmed against 30 m open field site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788.
2. The fundamental of the EUT was investigated in three orthogonal orientations X, Y and Z. It was determined that **X** orientation was worst-case orientation. Therefore, all final radiated testing was performed with the EUT in **X** orientation.
3. The test procedure(s) in this report were performed in accordance as following.
 - ◆ ANSI C63.10-2013
 - ◆ KDB 558074 D01 v05r02

5. Measurement uncertainty

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.10-2013.

All measurement uncertainty values are shown with a coverage factor of $k=2$ to indicated a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and thus, can be compared directly to specified limits to determine compliance.

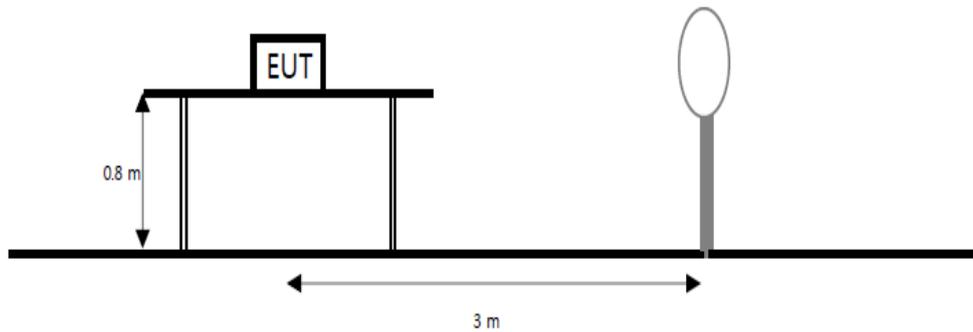
Parameter	Expanded uncertainty (±)	
Radiated spurious emissions	9 kHz ~ 30 MHz:	2.3 dB
	30 MHz ~ 300 MHz	5.4 dB
	300 MHz ~ 1 000 MHz	5.5 dB
	Above 1 GHz	6.7 dB

6 Test results

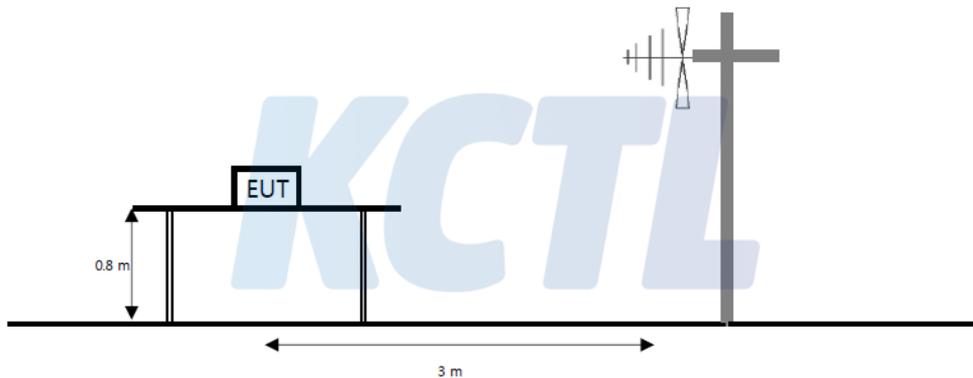
6.1. Radiated spurious emissions & band edge

Test setup

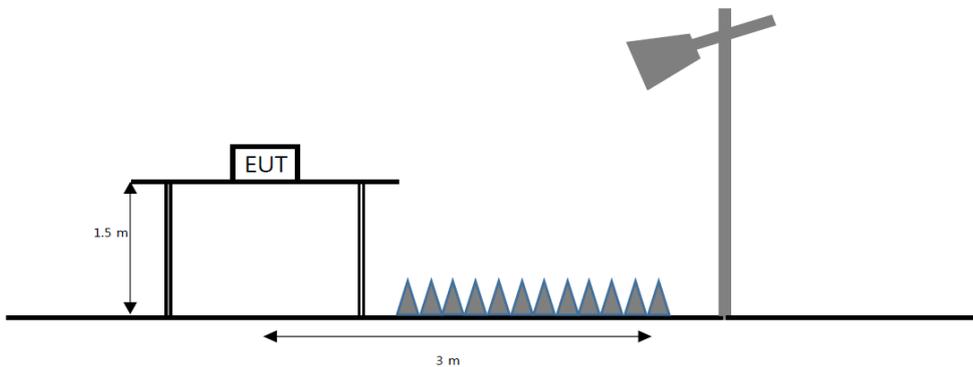
The diagram below shows the test setup that is utilized to make the measurements for emission from 9 kHz to 30 MHz Emissions



The diagram below shows the test setup that is utilized to make the measurements for emission from 30 MHz to 1 GHz emissions.



The diagram below shows the test setup that is utilized to make the measurements for emission from 1 GHz to the tenth harmonic of the highest fundamental frequency or to 40 GHz emissions, whichever is lower.



Limit**FCC**

According to section 15.209(a), except as provided elsewhere in this subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Frequency (MHz)	Field strength ($\mu\text{V}/\text{m}$)	Measurement distance (m)
0.009 - 0.490	2 400/F(kHz)	300
0.490 - 1.705	24 000/F(kHz)	30
1.705 - 30	30	30
30 - 88	100**	3
88 - 216	150**	3
216 - 960	200**	3
Above 960	500	3

**Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54–72 MHz, 76–88 MHz, 174–216 MHz or 470–806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., Section 15.231 and 15.241.

According to section 15.205(a) and (b), only spurious emissions are permitted in any of the frequency bands listed below:

MHz	MHz	MHz	GHz
0.009 - 0.110	16.42 - 16.423	399.9 - 410	4.5 - 5.15
0.495 - 0.505	16.694 75 - 16.695 25	608 - 614	5.35 - 5.46
2.173 5 - 2.190 5	16.804 25 - 16.804 75	960 - 1 240	7.25 - 7.75
4.125 - 4.128	25.5 - 25.67	1 300 - 1 427	8.025 - 8.5
4.177 25 - 4.177 75	37.5 - 38.25	1 435 - 1 626.5	9.0 - 9.2
4.207 25 - 4.207 75	73 - 74.6	1 645.5 - 1 646.5	9.3 - 9.5
6.215 - 6.218	74.8 - 75.2	1 660 - 1 710	10.6 - 12.7
6.267 75 - 6.268 25	108 - 121.94	1 718.8 - 1 722.2	13.25 - 13.4
6.311 75 - 6.312 25	123 - 138	2 200 - 2 300	14.47 - 14.5
8.291 - 8.294	149.9 - 150.05	2 310 - 2 390	15.35 - 16.2
8.362 - 8.366	156.524 75 - 156.525	2 483.5 - 2 500	17.7 - 21.4
8.376 25 - 8.386 75	25	2 690 - 2 900	22.01 - 23.12
8.414 25 - 8.414 75	156.7 - 156.9	3 260 - 3 267	23.6 - 24.0
12.29 - 12.293	162.012 5 - 167.17	3 332 - 3 339	31.2 - 31.8
12.519 75 - 12.520 25	167.72 - 173.2	3 345.8 - 3 358	36.43 - 36.5
12.576 75 - 12.577 25	240 - 285	3 600 - 4 400	Above 38.6
13.36 - 13.41	322 - 335.4		

The field strength of emissions appearing within these frequency bands shall not exceed the limits shown in section 15.209. At frequencies equal to or less than 1 000 MHz, compliance with the limits in section 15.209 shall be demonstrated using measurement instrumentation employing a CISPR quasi-peak detector. Above 1 000 MHz, compliance with the emission limits in section 15.209 shall be demonstrated based on the average value of the measured emissions. The provisions in section 15.35 apply to these measurements.

Test procedure

ANSI C63.10-2013

Test settings**Peak field strength measurements**

1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
2. RBW = as specified in table
3. VBW \geq (3 \times RBW)
4. Detector = peak
5. Sweep time = auto
6. Trace mode = max hold
7. Allow sweeps to continue until the trace stabilizes

Table. RBW as a function of frequency

Frequency	RBW
9 kHz to 150 kHz	200 Hz to 300 Hz
0.15 MHz to 30 MHz	9 kHz to 10 kHz
30 MHz to 1 000 MHz	100 kHz to 120 kHz
> 1 000 MHz	1 MHz

Average field strength measurements

1. Analyzer center frequency was set to the frequency of the radiated spurious emission of interest
2. RBW = 1 MHz
3. VBW = 1/T \geq 1 Hz
4. Averaging type was set to RMS to ensure that video filtering was applied in the power domain
5. Detector = peak
6. Sweep time = auto
7. Trace mode = max hold
8. Trace was allowed to run for at least 50 times(1/duty cycle) traces

Notes:

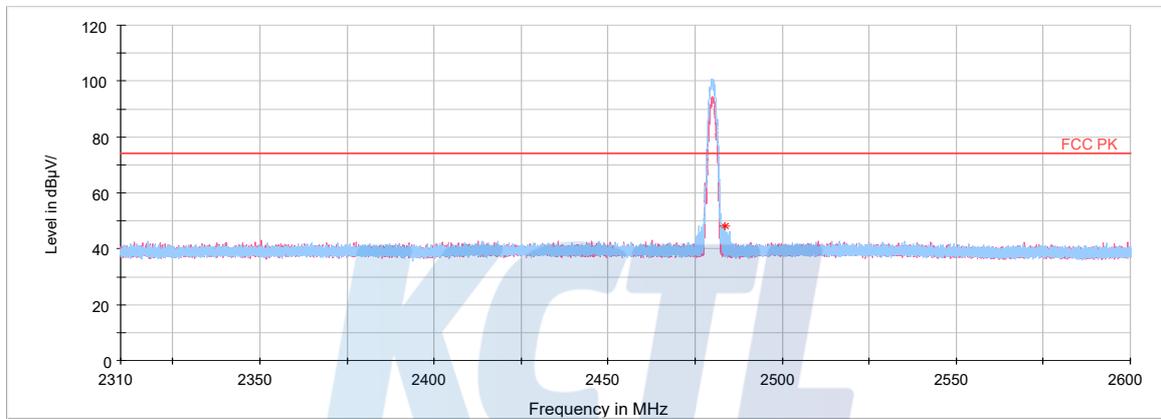
1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 1 MHz for Peak detection and frequency above 1 GHz. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 3 kHz(\geq 1/T) for Average detection (AV) at frequency above 1 GHz.
2. $f < 30$ MHz, extrapolation factor of 40 dB/decade of distance. $F_d = 40\log(D_m/D_s)$
 $f \geq 30$ MHz, extrapolation factor of 20 dB/decade of distance. $F_d = 20\log(D_m/D_s)$
 Where:
 F_d = Distance factor in dB
 D_m = Measurement distance in meters
 D_s = Specification distance in meters
3. Factors(dB) = Antenna factor(dB/m) + Cable loss(dB) + or Amp. gain(dB) + or F_d (dB)
4. The worst-case emissions are reported however emissions whose levels were not within 20 dB of respective limits were not reported.
5. Average test would be performed if the peak result were greater than the average limit.
6. ¹⁾ means restricted band.

6.2. Test results

GFSK_Band-edge

Frequency (MHz)	Pol. (V/H)	Reading (dB(μ V))	Ant. Factor (dB)	Amp. + Cable (dB)	DCF (dB)	Result (dB(μ V/m))	Limit (dB(μ V/m))	Margin (dB)
Peak data								
2 483.65	H	45.38	32.07	-29.21	-	48.24	74.00	25.76
Average Data								
No spurious emissions were detected within 20 dB of the limit.								

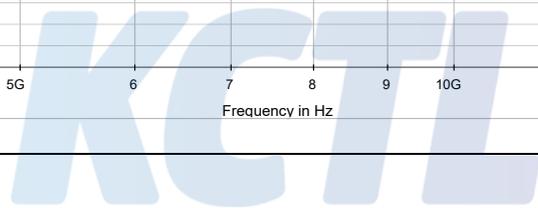
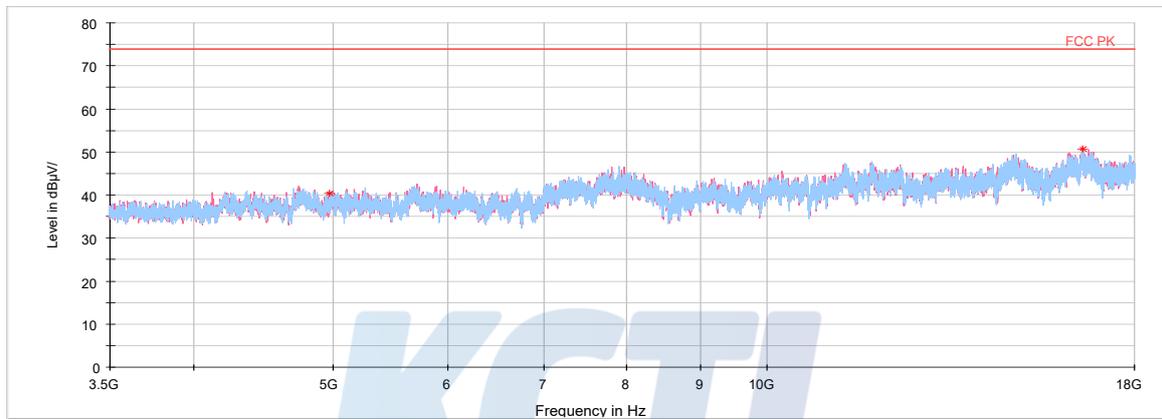
Horizontal/Vertical for Band-edge



GFSK Harmonic

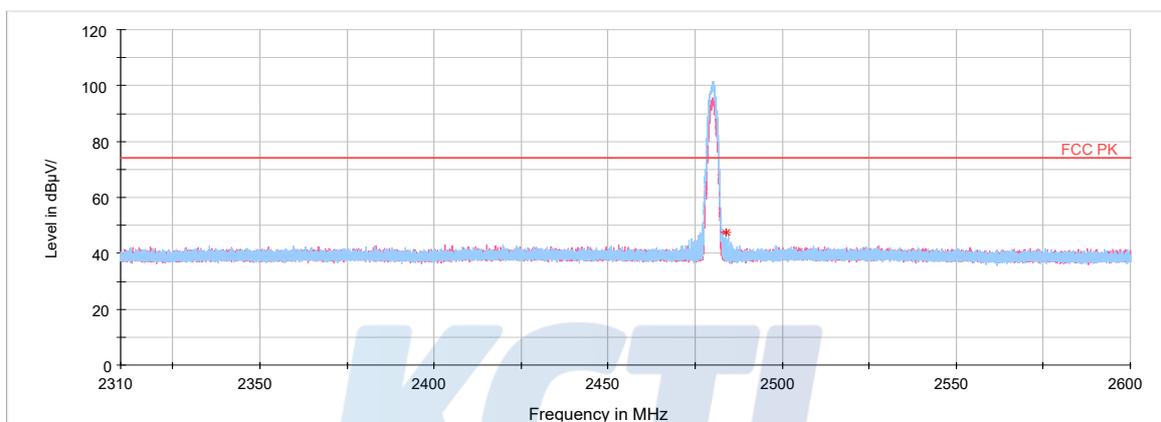
Frequency	Pol.	Reading	Ant. Factor	Amp. + Cable	DCF	Result	Limit	Margin
(MHz)	(V/H)	(dB(μV))	(dB)	(dB)	(dB)	(dB($\mu V/m$))	(dB($\mu V/m$))	(dB)
Peak data								
4 973.11	H	60.80	33.99	-54.43	-	40.36	74.00	33.64
Average Data								
No spurious emissions were detected within 20 dB of the limit.								

Horizontal/Vertical for 3.5 GHz ~ 18 GHz



8DPSK_Band-edge

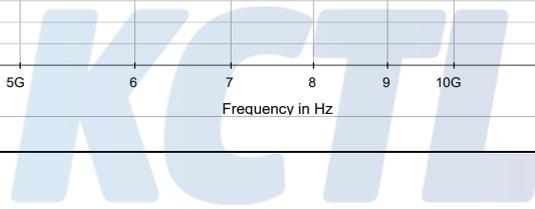
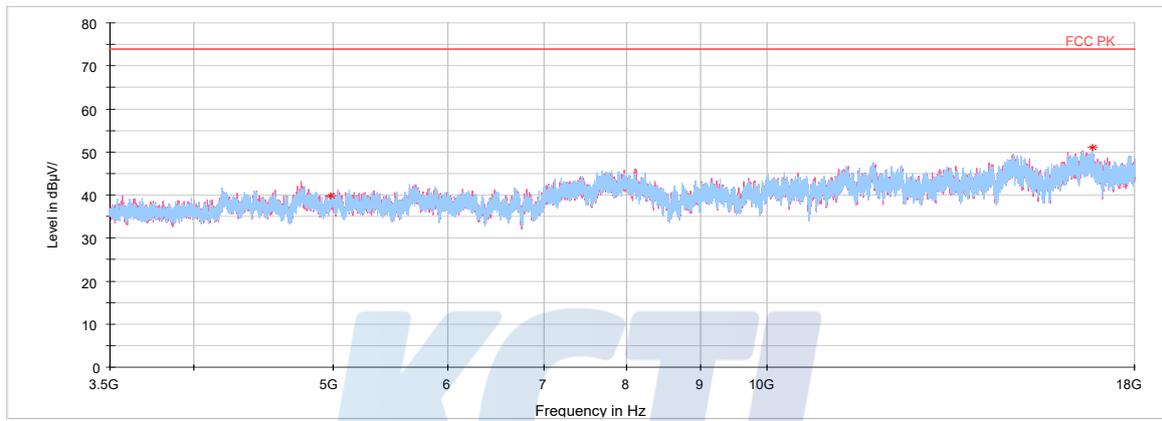
Frequency	Pol.	Reading	Ant. Factor	Amp. + Cable	DCF	Result	Limit	Margin
(MHz)	(V/H)	(dB(μV))	(dB)	(dB)	(dB)	(dB($\mu V/m$))	(dB($\mu V/m$))	(dB)
Peak data								
2 483.70	H	44.56	32.07	-29.21	-	47.42	74.00	26.58
Average Data								
No spurious emissions were detected within 20 dB of the limit.								

Horizontal/Vertical for Band-edge**KCTL**

8DPSK_Harmonic

Frequency	Pol.	Reading	Ant. Factor	Amp. + Cable	DCF	Result	Limit	Margin
(MHz)	(V/H)	(dB(μV))	(dB)	(dB)	(dB)	(dB($\mu V/m$))	(dB($\mu V/m$))	(dB)
Peak data								
4 981.72	V	60.10	33.99	-54.28	-	39.81	74.00	34.19
Average Data								
No spurious emissions were detected within 20 dB of the limit.								

Horizontal/Vertical for 3.5 GHz ~ 18 GHz



7. Measurement equipment

Equipment Name	Manufacturer	Model No.	Serial No.	Next Cal. Date
Spectrum Analyzer	R&S	FSV40	100989	21.01.03
Power Sensor	R&S	NRP-Z81	1137.9009.02-106224-tg	21.05.25
Attenuator	R&S	DNF Dämpfungsglied 10 dB in N-50 Ohm	31210	21.05.11
Signal Generator	R&S	SMB100A	176206	21.01.21
Vector Signal Generator	R&S	SMBV100A	257566	21.07.13
DC Power Supply	AGILENT	E3632A	MY40001543	21.05.11
Horn antenna	ETS.lindgren	3117	155787	20.10.24
Horn antenna	ETS.lindgren	3116	00086632	21.02.17
Attenuator	API Inmet	40AH2W-10	12	21.05.12
Broadband Pre-Amplifier	SCHWARZBECK	BBV9718	216	21.07.28
AMPLIFIER	L-3 Narda-MITEQ	AMF-7D-01001800 -22-10P	2031196	21.02.12
AMPLIFIER	L-3 Narda-MITEQ	JS44-18004000-33-8P	2000996	21.01.22
Antenna Mast	Innco Systems	MA4000-EP	303	-
Turn Table	Innco Systems	DT2000	79	-
High pass Filter	WT	WT-A1698-HS	WT160411001	21.05.11
Bluetooth Tester	TESCOM	TC-3000C	3000C000270	21.07.28

End of test report